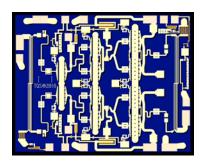
# TriQuint 🌘 **SEMICONDUCTOR**

## **Applications**

- Point-to-Point Radio
- Communication



### **Product Features**

Frequency Range: 17.5 – 20 GHz Power: 32.5 dBm Psat, 31.5 dBm P1dB

Gain: 23 dB

TOI: 43 dBm @ 22 dBm SCL

Return Loss: 18 dB

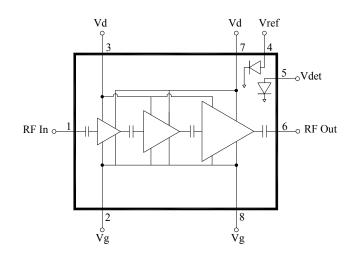
NF: 6 dB

Integrated Power Detector

Bias: Vd = 6 V, Id = 900 mA, Vg = -0.7 V Typical

Dimensions: 2.4 x 1.9 x 0.1 mm

## Functional Block Diagram



### **General Description**

The TriQuint TGA4532 is a K-Band Power Amplifier. The TGA4532 operates from 17.5 to 20 GHz and is designed using TriQuint's power pHEMT production process.

The TGA4532 typically provides 31.5 dBm of output power at 1dB gain compression with small signal gain of 23 dB. Third Order Intercept is 43 dBm at 22 dBm SCL.

The TGA4532 is ideally suited for Point-to-Point Radio, and K-band communications.

Lead-free and RoHS compliant

## **Bond Pad Configuration**

Bond Pad #	Symbol
1	RF In
2, 8	Vg
3, 7	Vd
4	Vref
5	Vdet
6	RF Out

## **Ordering Information**

Part No.	<b>ECCN</b>	Description		
TGA4532	3A001.b.2.c	K-band Power Amplifier		
Standard order aty = 100 pieces				

Standard order qty = 100 pieces.

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## **Specifications**

### **Absolute Maximum Ratings**

Parameter	Rating
Drain to Gate Voltage, Vd - Vg	10 V
Drain Voltage,Vd	+6.5 V
Gate Voltage,Vg	-4 to 0 V
Drain Current, Id	1960 mA
Gate Current, Ig	-8.2 to 113 mA
Power Dissipation, Pdiss	12.7 W
RF Input Power, CW, $50\Omega$ , T = 25°C	26 dBm
Channel Temperature, Tch	200 °C
Mounting Temperature	320 °C
(30 Seconds)	320 C
Storage Temperature	-40 to 150 °C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

## **Recommended Operating Conditions**

Parameter	Min	Typical	Max	Units
Vd		6		V
Id		900		mA
Id_drive (Under RF Drive)		1200		mA
Vg		-0.7		V

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

## **Electrical Specifications**

Test conditions unless otherwise noted: 25°C, Vd = 6 V, Id = 900 mA, Vg = -0.7 V Typical.

rest conditions unless otherwise noted. 25 c, va ov,	ia 700 iii i, v 5	0.7 V Typicai.		
Parameter	Min	Typical	Max	Units
Operational Frequency Range	17.7		19.7	GHz
Gain	21	23		dB
Input Return Loss		-18	-14	dB
Output Return Loss		-18	-14	dB
Output Power @ Saturation		32.5		dBm
Output Power @ 1 dB Gain Compression	30	31.5		dBm
Output TOI @ 22 dBm SCL	40	43		dBm
Noise Figure		6		dB
Gain Temperature Coefficient		-0.025		dB/°C
Power Temperature Coefficient		-0.005		dBm/°C

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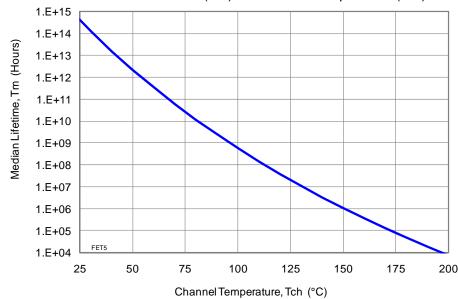


## **Specifications (cont.)**

## **Thermal and Reliability Information**

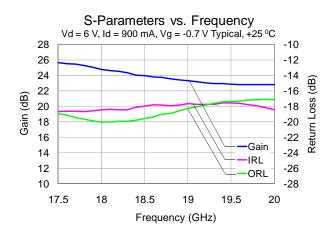
Parameter	Condition	Rating
Thermal Resistance, $\theta_{JC}$ , measured to back of package	Tbase = 70 °C	$\theta_{\rm JC} = 8.51  ^{\circ}{\rm C/W}$
Channel Temperature (Tch), and Median Lifetime (Tm)	Tbase = $70  ^{\circ}\text{C}$ , $Vd = 6  V$ , $Id = 900  $	Tch = 116 °C
Chainlet Temperature (TCn), and Median Effetime (Tm)	mA, $Pdiss = 5.4 W$	Tm = 6.3 E+7 Hours
Channel Temperature (Tch), and Median Lifetime (Tm)	Tbase = $70  ^{\circ}$ C, Vd = $6  \text{V}$ , Id = $1200  \text{C}$	Tch = 116 °C
Under RF Drive	mA, Pout = 32.5 dBm, Pdiss = 5.4 W	Tm = 6.3 E+7 Hours

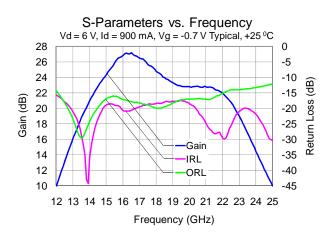
#### Median Lifetime (Tm) vs. Channel Temperature (Tch)

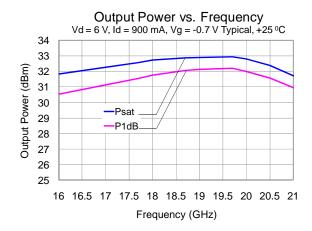


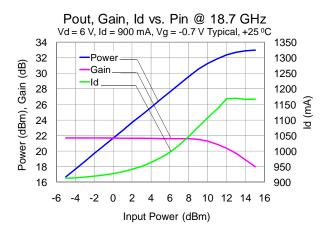


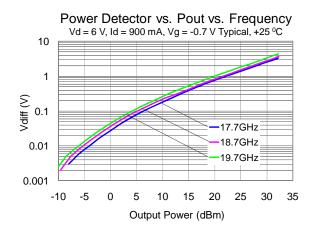
## **Typical Performance**

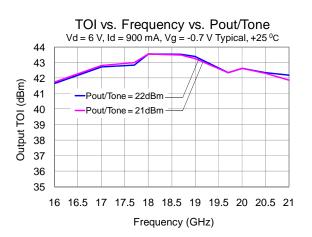












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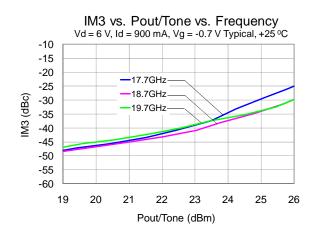
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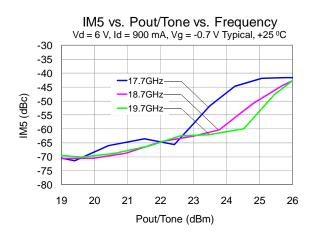
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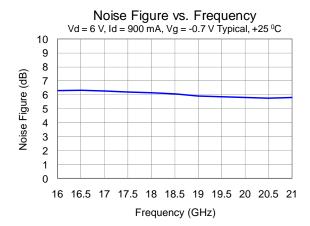
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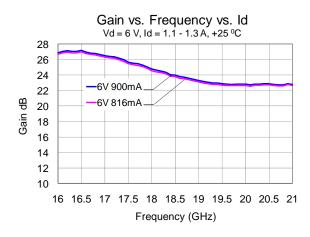


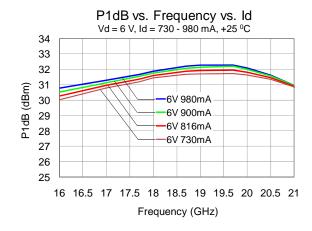
## **Typical Performance (cont.)**

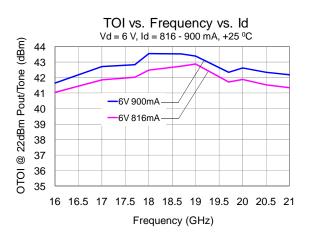












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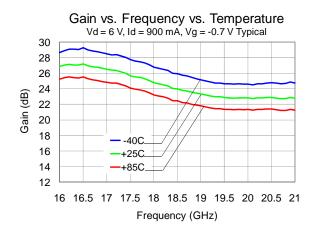
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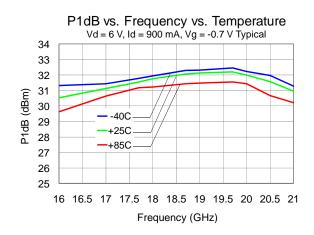
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## **Typical Performance (cont.)**

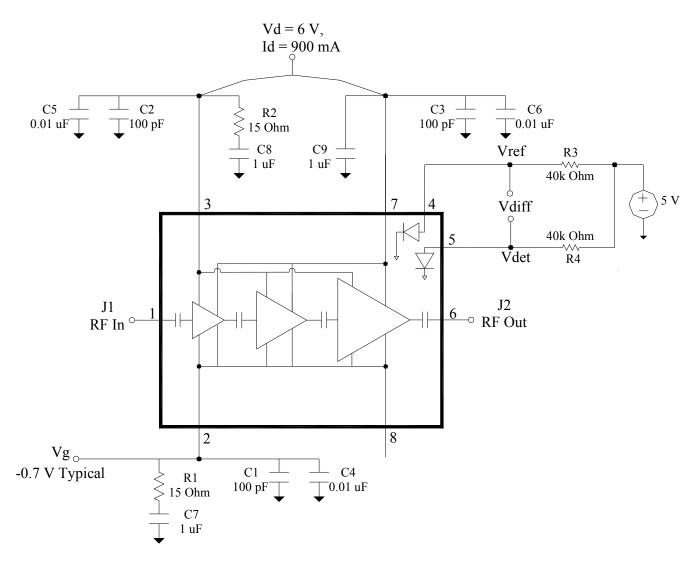




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## **Application Circuit**



Vg can be biased from either side (bond pad 2 or bond pad 8), and the non-biased side can be left open. Vd must be biased from both sides (bond pad 3 and bond pad 7).

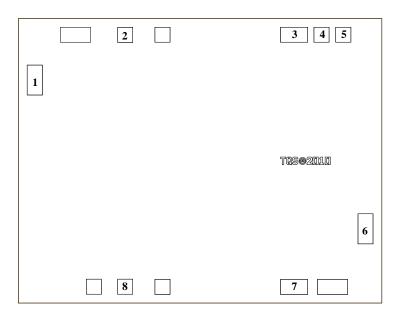
Bias-up Procedure	Bias-down Procedure
Vg set to -1.5 V	Turn off RF supply
Vd set to +6 V	Reduce Vg to -1.5V. Ensure Id ~ 0 mA
Adjust Vg more positive until quiescent Id is 900 mA. This will be $\sim$ Vg = -0.7 V	Turn Vd to 0 V
Apply RF signal to RF Input	Turn Vg to 0 V

## **TGA4532**

K-Band Power Amplifier



## **Bond Pad Description**

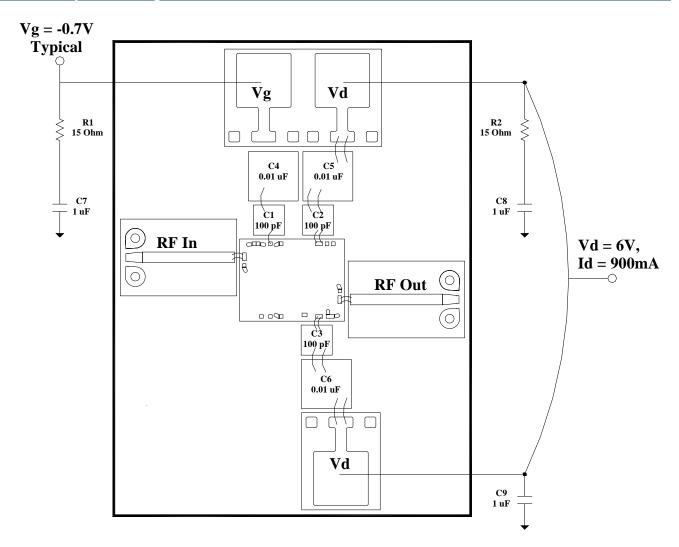


<b>Bond Pad</b>	Symbol	Description
1	RF In	Input, matched to 50 ohms
2, 8	Vg	Gate voltage. ESD protection included; Bias network is required; can be biased from either side (bond pad 2 or bond pad 8), and non-biased side can be left opened; see Application Circuit on page 7 as an example.
3, 7	Vd	Drain voltage. Bias network is required; must be biased from both sides; see Application Circuit on page 7 as an example.
4	Vref	Reference diode output voltage.
5	Vdet	Detector diode output voltage. Varies with RF output power.
6	RF Out	Output, matched to 50 ohms

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## **Assembly Drawing**



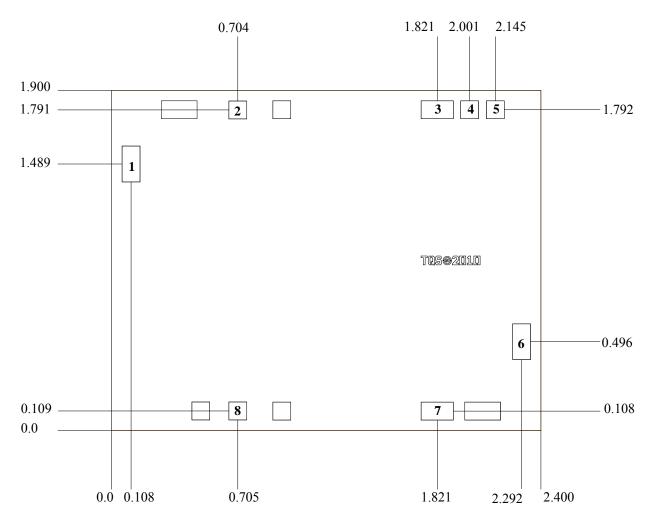
#### **Bill of Material**

Ref Des	Value	Description	Manufacturer	Part Number
C1, C2, C3	100 pF	Cap, 50V, 25%, Single Layer Cap	various	
C4, C5, C6	0.01 uF	Cap, 50V, 10%, SMD	various	
C7, C8, C9	1 uF	Cap, 50V, 5%	various	
R1, R2	15 Ohms	Res, 1/4W, 5%	various	

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## **Mechanical Information**



Unit: millimeters Thickness: 0.10

Die x, y size tolerance: +/- 0.050

Chip edge to bond pad dimensions are shown to center of pad

Ground is backside of die

<b>Bond Pad</b>	Symbol	Pad Size
1	RF In	0.100 x 0.200
2, 8	Vg	0.100 x 0.100
3, 7	Vd	0.180 x 0.100
4	Vred	0.100 x 0.100
5	Vdet	0.100 x 0.100
6	RF Out	0.100 x 0.200

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## **Product Compliance Information**

#### **ESD Information**



## **Caution! ESD-Sensitive Device**

ESD Rating: 1A

Value: Passes  $\geq 250$ V min.

Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

#### **ECCN**

US Department of Commerce 3A001.b.2.c

### **Solderability**

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A  $(C_{15}H_{12}Br_4O_2)$  Free
- PFOS Free
- SVHC Free

## **Assembly Notes**

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.
- Organic attachment (i.e. epoxy) can be used in low-power applications.
- Curing should be done in a convection oven; proper exhaust is a safety concern.

#### Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300°C to 3-4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

#### Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonics are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

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## **TGA4532**

### K-Band Power Amplifier



### **Contact Information**

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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For technical questions and application information:

Email: info-networks@tqs.com

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